

**Search Notes**

Application/Control No.

10/791,815

Examiner

David Buttner

Applicant(s)/Patent under  
Reexamination

FUJISAWA ET AL.

Art Unit

1712

**SEARCHED**

Class	Subclass	Date	Examiner
524	120	7/21/2005	DB
524	126	7/21/2005	DB
524	128	7/21/2005	DB
524	150	7/21/2005	DB
524	151	7/21/2005	DB
473	351	7/21/2005	DB
473	356	7/21/2005	DB
473	365	7/21/2005	DB
473	378	7/21/2005	DB

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
west	7/21/2005	DB
chem ab	7/21/2005	DB
east	7/21/2005	DB